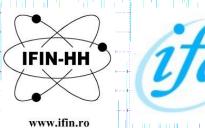




MINISTERUL CERCETĂRII, INOVĂRII ȘI DIGITALIZĂRII



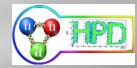
TRD2D status

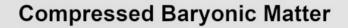
Alex Bercuci

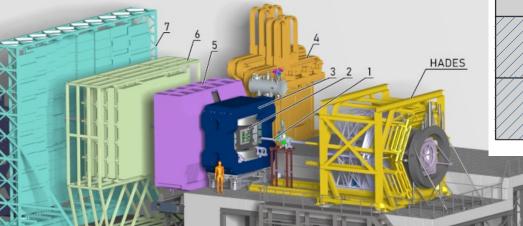
46th Collaboration Meeting 22nd October 2025 Lanzhou, China



The TRD2D @ CBM







- 1: Time-Zero Detector & Beam Diagnostics
- 2: Silicon Tracking System / Micro Vertex Detector
- 3: Superconducting Dipole Magnet
- 4: Muon Chambers

- 5: Ring Imaging Cherenkov Detector
- 6: Transition Radiation Detector
- 7: Time of Flight Detector
- 8: Forward Spectator Detector

• **11.5 m**² read-out area (11.66)

3

3

3

3

3

3

5

5

5

3

3

1

3

3

5

5

5

5

3

3

3

3

* > **10**⁵ read-out channels (115200)

3

- \approx **3k** channels/detector (2880)
- 10 detectors x 4 layers

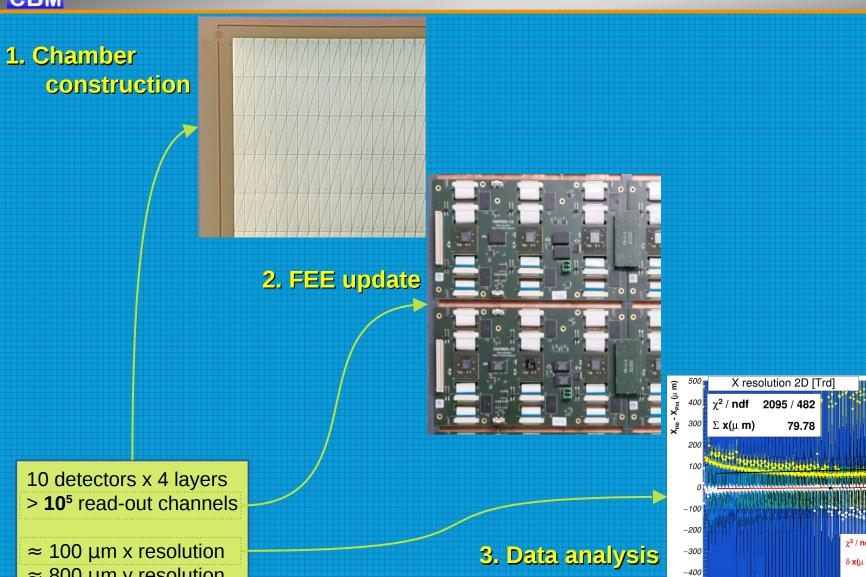
10⁵ particles/cm²/s

- \approx 100 µm x resolution
- $\approx 800 \ \mu m \ y \ resolution$ e/ π separation



Overview





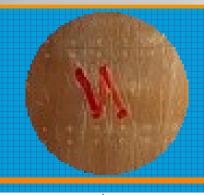
≈ 800 µm y resolution

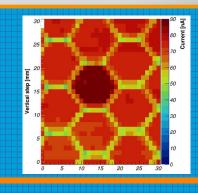


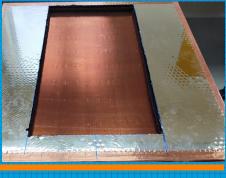
I. Chamber construction



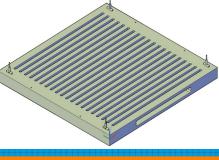
Prototype lessons

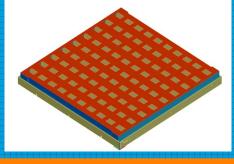


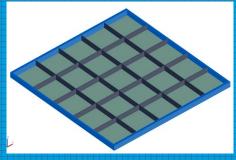




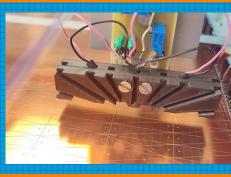
New designs

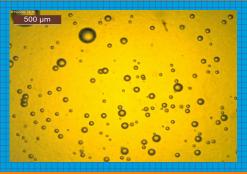


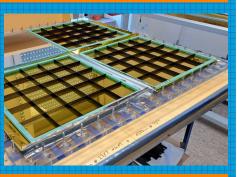




QA tools & procedures







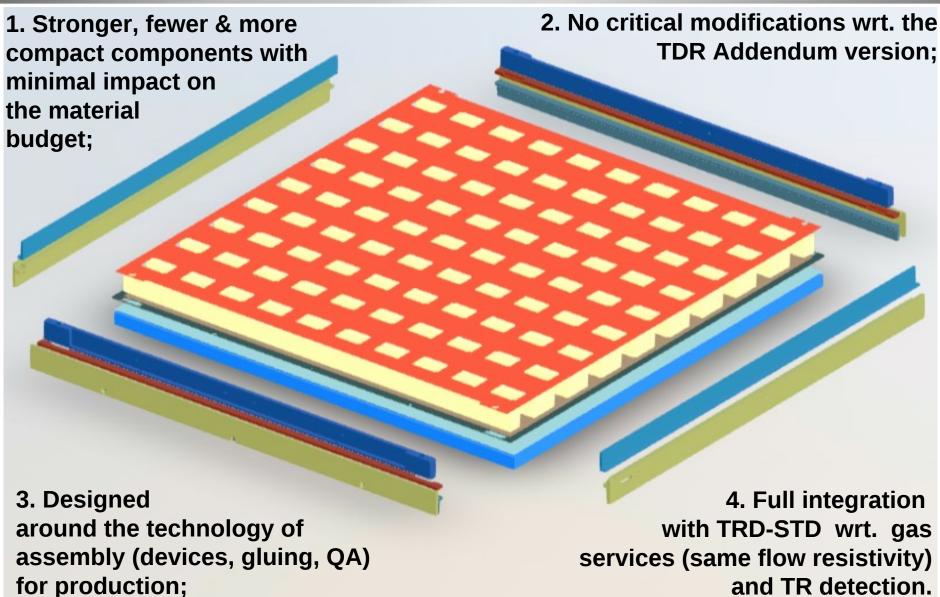
Production

PRR / FoS

In progress Q2/26

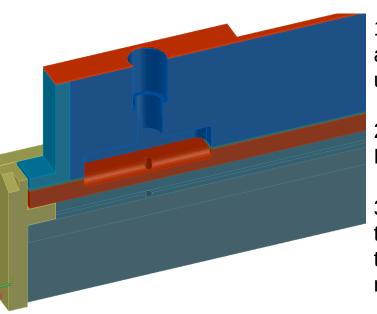












1. Gas inlets are of the same size as the TRD-STD, to allow for a unique gas system.

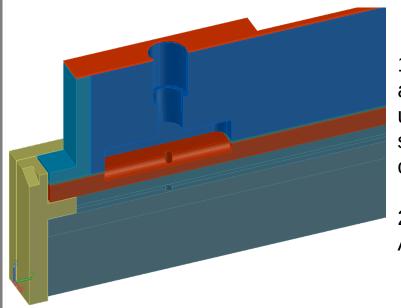
- 2. Avoid gas feed through the Pad-plane
- 3. Entrance windows employ the same structure as TRD-STD to provide same gas flow resistivity

GAS IN/OUT

https://indico.gsi.de/event/23197/#5-trd-2d-chamber-design-update

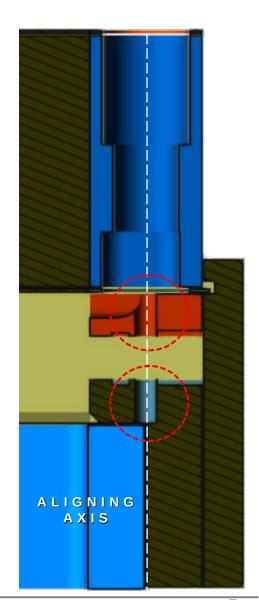






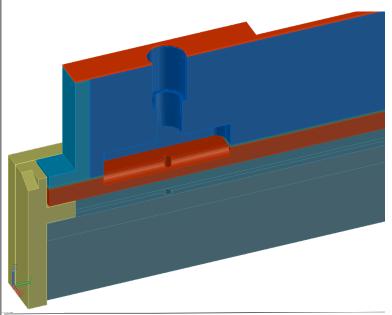
- 1. A system of pin holes, aligned with the gas inlets are used together with a special device to align all components.
- 2. See S9 for its use during Assembly.

https://indico.gsi.de/event/23197/#5-trd-2d-chamber-design-update







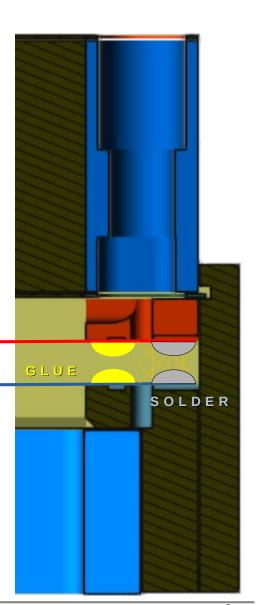


https://indico.gsi.de/event/23197/#5-trd-2d-chamber-design-update

- 1. Wire planes are installed in parallel. Flexibility.
- 2. They are kept in place only by glue for better alignment.
- 3. Possible replacement of wires during installation in case of error.

anode wire plane

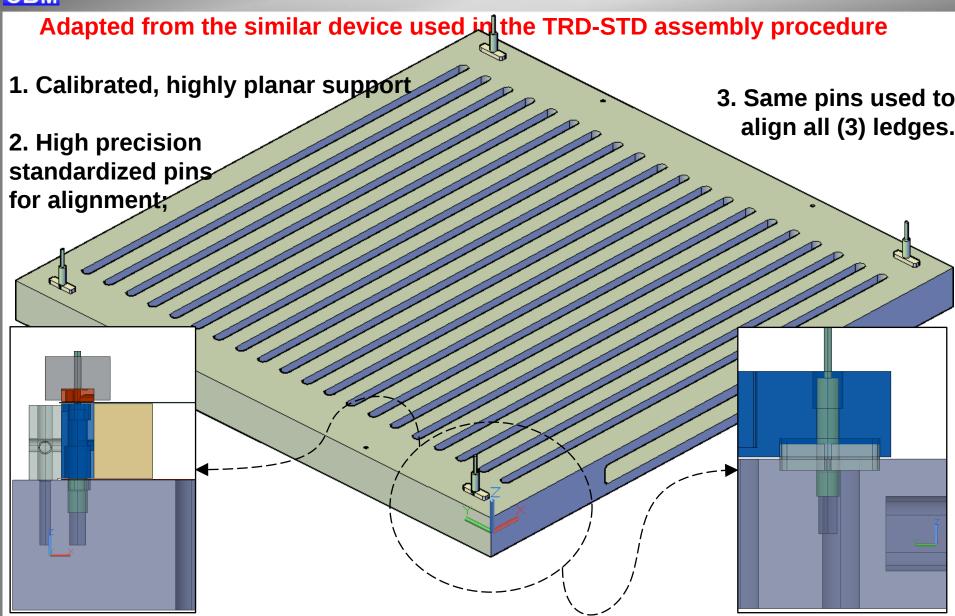
cathode wire plane





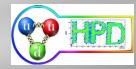
Assembly device

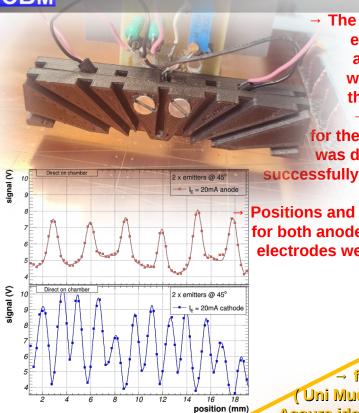






Tools and procedures





https://indico.gsi.de/event/ 23101/#2-electronicintegration → The Uni Muenster
efforts to build
a new, reliable
were joined by
the Buch team.
→ A prototype
for the analog stage
was developed and
successfully tested in real
conditions.
Positions and wire tensions
for both anode and cathode
electrodes were measured.



- The spacers are borrowed from the RPC where they are used for spacing the glass planes.
 - → Diameter 2mm x Height 170µm
 - → Self adhesion layer for easy installation on the support.

→ foil gluing on the same stretcher
(Uni Muenster) as for the TRD-STD detectors.
Assure identical flow resistivity.

window assembly

https://indico.gsi.de/event/ 23152/#4-on-glueing-processesin-cham

https://indico.gsi.de/event/23236/#5-trd-2d-entrance-window-updat



Chamber production milestones



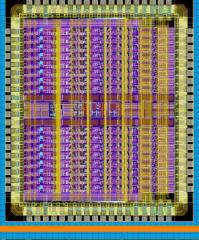
	Name	Qtr 3, 2025			Qtr 4, 2025			Qtr 1, 2026			Qtr
		Jul	Aug	Sep	Oct	Nov	Dec	Jan	Feb	Mar	Ар
1	Internal evaluation of design										
2	Design update										
3	Company contacts / offers										
4	Secure financial					J					
5	Produce entrance window										
6	Glue foil Uni Muenster			-			Н				0
7	Produce device assembly										
8	Produce TRD2D components										
9	TRD2D assembly						-	J			
10	TRD2D QA Bucharest										
11	TRD2D QA Muenster										
12	TRD2D QA GSI									Y	

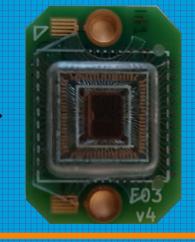


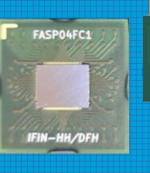
II. FEE updates

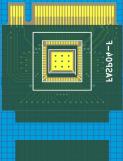


FASP ASIC
Production &
Bonding





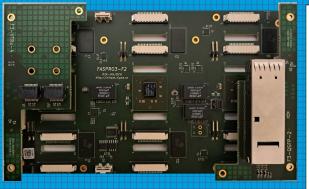




FEB designs



6xFASP @ mCBM 21&22



To be continued

12xFASP @ mCBM 25

QA tools & procedures

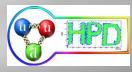
In progress

Production

In progress



FEB



1. ASIC - FASP Production

- → Test production (0.2k) / wire bonding > 90% dice (+bonding) efficiency (mCBM 21-24)
- → Test production (0.5k) / flip-chip bonding (mCBM 25)
 - → ~ 80% bonding efficiency (first batch)
 - → ~ 50% bonding efficiency (second batch) !!
 - → further problems when bonded to FEB

2. ASIC Engineering run

 \rightarrow ~ 200% (17k) of the CBM demand

3. New concept ASIC bonding

→ New substrate + wire bonding (correlated with changes in the pad-plane)

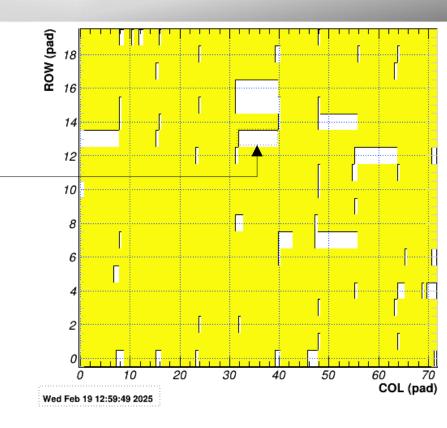
Pad-plane

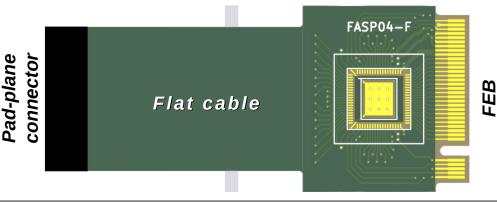
connector

- → design ready
- → engineering in progress (Hybrid Swiss)
- → production and testing Q1/26

4. FEB updates

- → reduced component cluttering
- → increased redundancy
- → improvements in DAQ (CDR)

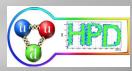


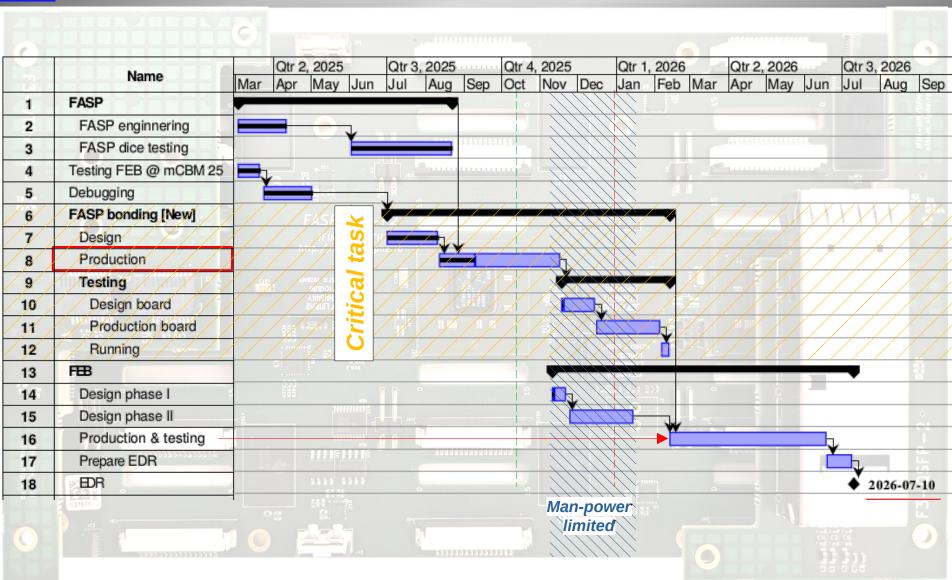


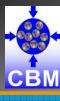
connector



FEE production milestones



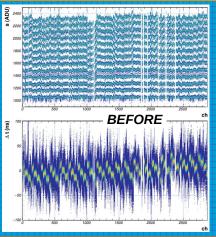


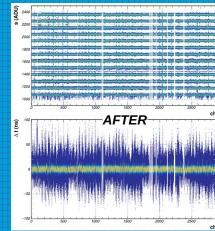


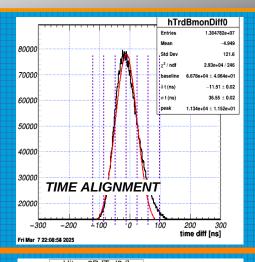
III. Data analysis



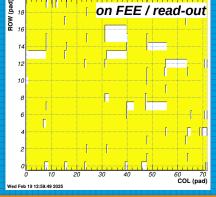
FEB calibration

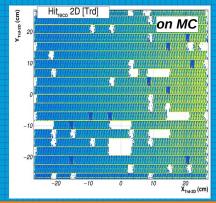


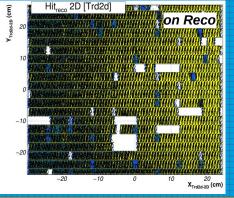




Read-out and Channel masking







Position Reco & Resolution

Position reference → [alignment] Systematic effects (Cl. Size) → [realistic MC] Error parametrization (Pulls) → [STS + MC]

CM 46 → milestone Q2/26

Energy Reco & Resolution

PID reference → [ToF tracking]
→ [secondary vertices]

in progress milestone Q2/26

22/10/25



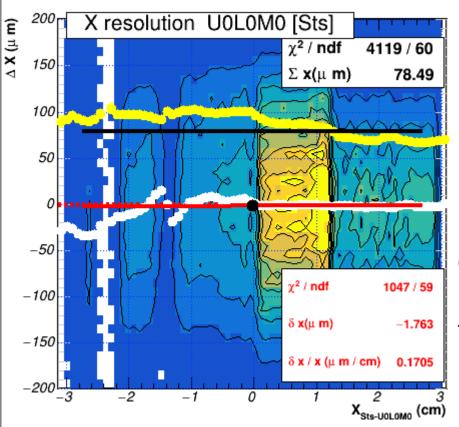
Position reference definitions alignment



Basic plots used for this detector alignment ("open box" approach)*

- $\rightarrow \Delta X = X_{Hit} X_{Trk}$;
 - \rightarrow mean of $\Delta X(X_{Hit})$; alignment; systematics (white/red)**
 - \rightarrow sigma of $\Delta X(X_{Hit})$; error parametrization; uncertainty (yellow/black)*





Info encrypted in such figure

- → describe only #real_objects
- → reference : anchor **position from geometry**
- → residual misalignment
 - \rightarrow x direction $\delta x = -1.76 \mu m$
 - \rightarrow z direction 17.97 cm x 0.17 μ m/cm \rightarrow δ z = 3.06 μ m
- → linearity of the systematics
 - \rightarrow for x > 0 system behaves as expected
- \rightarrow combined uncertainty (Σx) of track extrapolation (σx_{Trk}) and STS hit (σx_{Hit}); $\Sigma^2 x = \sigma^2 x_{Trk}(p, ...) + \sigma^2 x_{Hit}$
- \rightarrow $\Sigma x = 78.49 \mu m$ dominated by the track
- \rightarrow uncertainty depends on sensors combination and track quality.

https://indico.gsi.de/event/23052/#4-sts-alignment-with-3-hit-sts

- *) More complete and detailed results are presented in the back-up slides at the end of this talk.
- **) The color code is also meant for the back-up slides



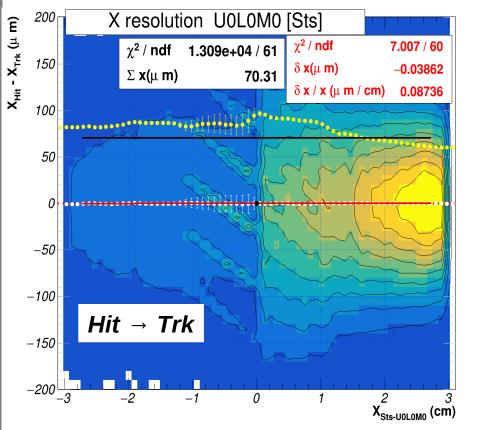
Position reference definitions residual mis-alignment influence

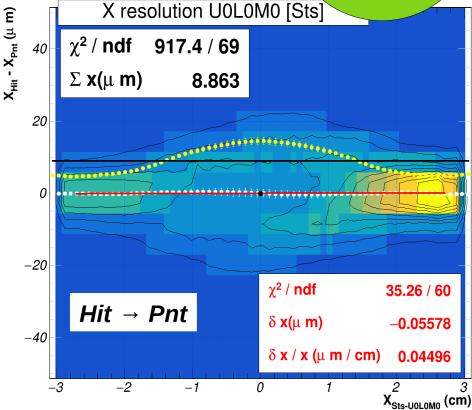


Do the same game with perfect alignment

- → indirect access to uncertainty info
 - → $[3604]\Sigma x = 78.49 \ \mu m$; $[MC]\Sigma x = 70.31 \ \mu m$; +11% difference !!
 - → [MC] $\Sigma x = 8.86 \mu m$ intrinsic average resolution ?!
 - \rightarrow uncertainty dependence on (θ, ϕ) smeared out by reco/tracking.

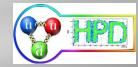
Au-Au Beam 1.23 AGeV Interaction mbias mCBM MC





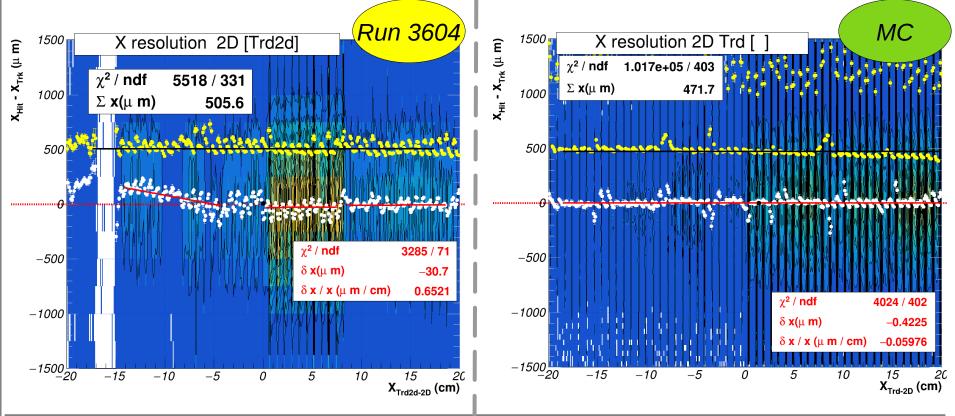


TRD2D residuals



 $X_{Hit} - X_{Trk}$

- Use 3 STS hit tracks to generate references
- Study Hit → Trk residuals for measurements and MC
 - → residual mis-alignment $\delta x = -30.7 \mu m$
 - → $[3604]\Sigma x = 505.6 \,\mu m$; $[MC]\Sigma x = 471.7 \,\mu m$; +7% difference !!
 - → systematic effects in the mCBM data reco visible!



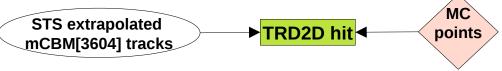


TRD2D systematic

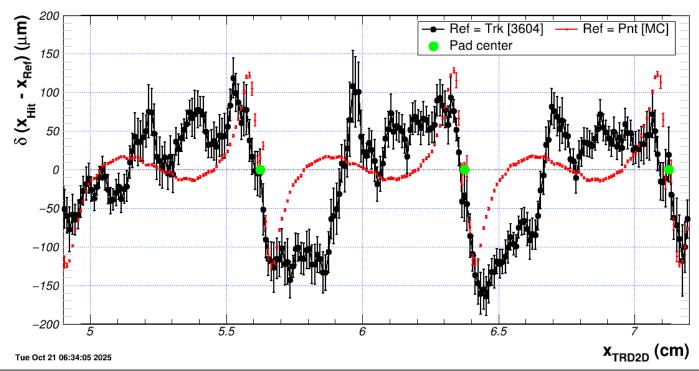


 X_{Hit}

• The system is ready to place side-by-side the model world of MC points with the #real_data driven, reconstructed tracks world.



- For clarity, only one type of TRD2D hits are shown (nRC,sz4)
- ✓ Observed TRD2D systematic effects range is described by MC.
- X The data is richer in "features"!



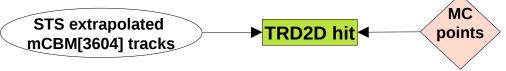


TRD2D systematic

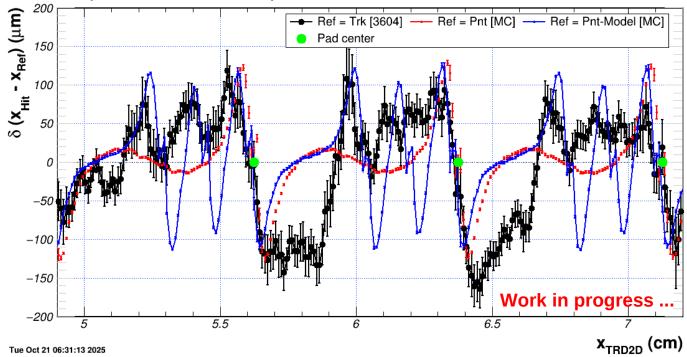


 X_{Hit}

• The system is ready to place side-by-side the model world of MC points with the #real_data driven, reconstructed tracks world.



- For clarity, only one type of TRD2D hits are shown (nRC,sz4)
- ✓ Observed TRD2D systematic effects range is described by MC.
- X The data is richer in "features"!
- ✓ Observed data drive #real detector reconstruction : Details of the chamber construction (wire to pads misalignment) are seen. Systematic effects are good!



22/10/25



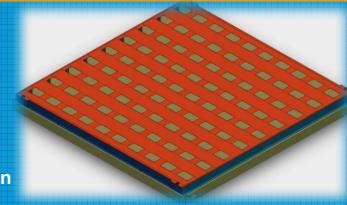
Conclusions



1. The CHAMBER

- A full reboot of the design/assembly was performed on 2025 based on lessons from the previous prototypes.
- Various updates are proposed for better integration in CBM and precise production.
- New prototype construction is starting
- New milestone Q2/26

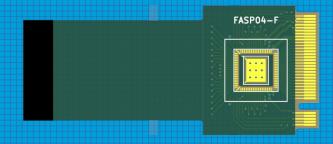
Laura, **Philipp** & Marian



2. The FEE

- Successful engineering run for the FASP dices for full CBM.
- Flexible bonding technology defined and ready for production.
- Modifications have to be propagated through the FEE/DAQ chain
- New milestone Q3/26

Claudiu



3. The DATA

- mCBM data and MC can be joined to shed light on the detector systematic effects. Sensitivity to construction details reconfirmed.
- Learning curve (calibrations, LUT) for analysis production is steep but populated with very good data.
- Milestone Q2/26 for performance paper.

Alex

Thank you





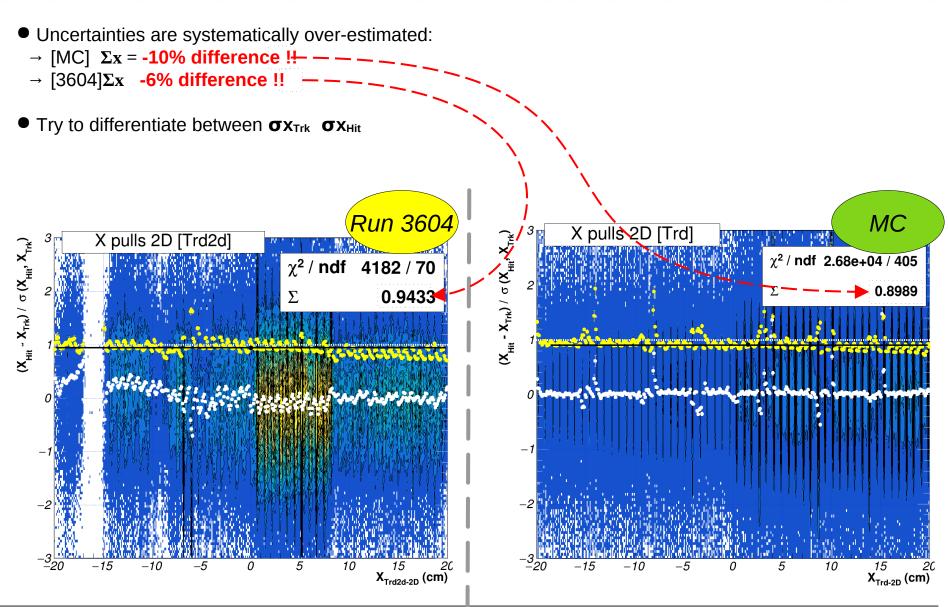
BACKUP



TRD2D pulls



 $X_{Hit} - X_{Trk}$



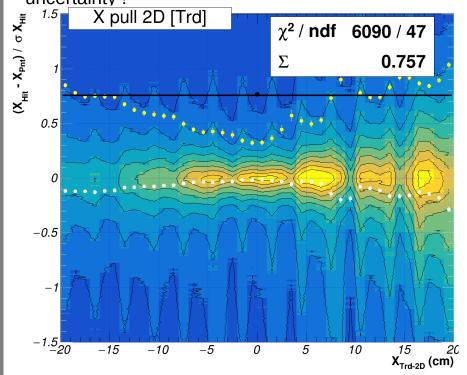


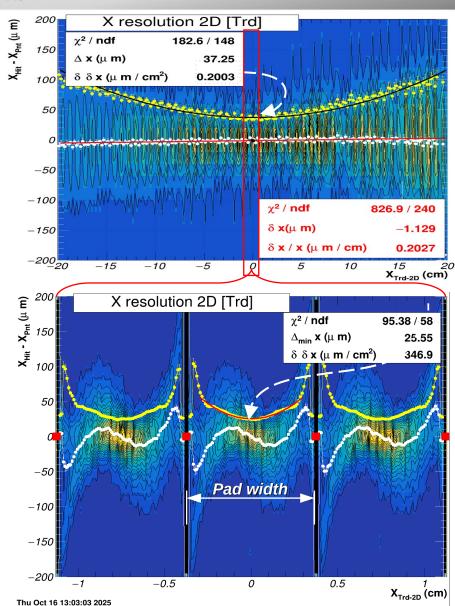
TRD2D uncertainty



$$X_{Hit} - X_{Pnt}$$

- TRD2D Uncertainty are systematically over-estimated:
 - → σx overestimate by more than -25% difference!!
 - → σx >= 25.5 μm !!
- \rightarrow σx depends on (θ, ϕ) and pad topology. Both dependencies are not described by the reco!
 - → Systematic effects $\delta x = \pm 50 \mu m$ are visible.
- However since σ_{Trk} ~ 450 µm ~ 10 x σ_{Hit} tracks at mCBM are not precise enough to constrain TRD2D x uncertainty!

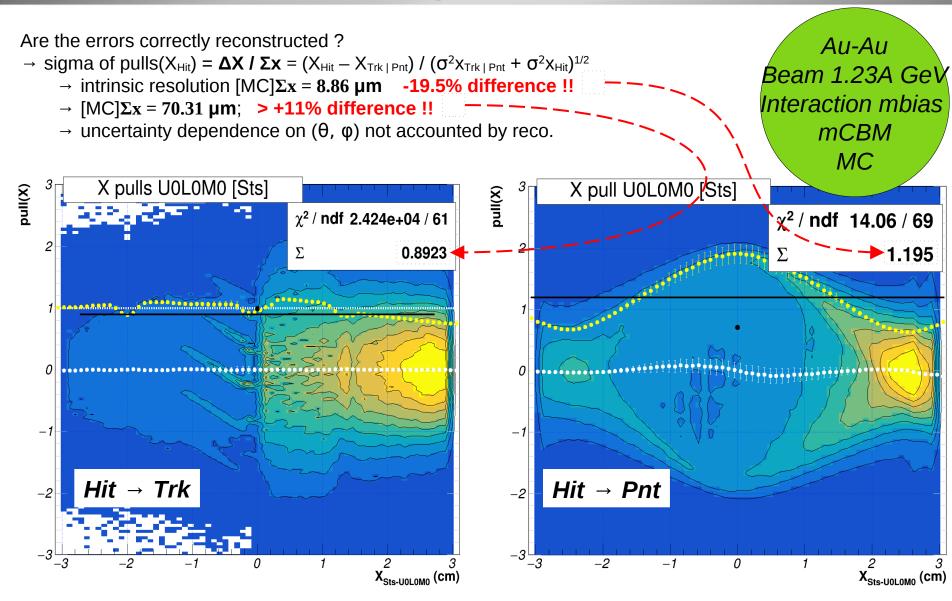






Position reference definitions uncertainty influence



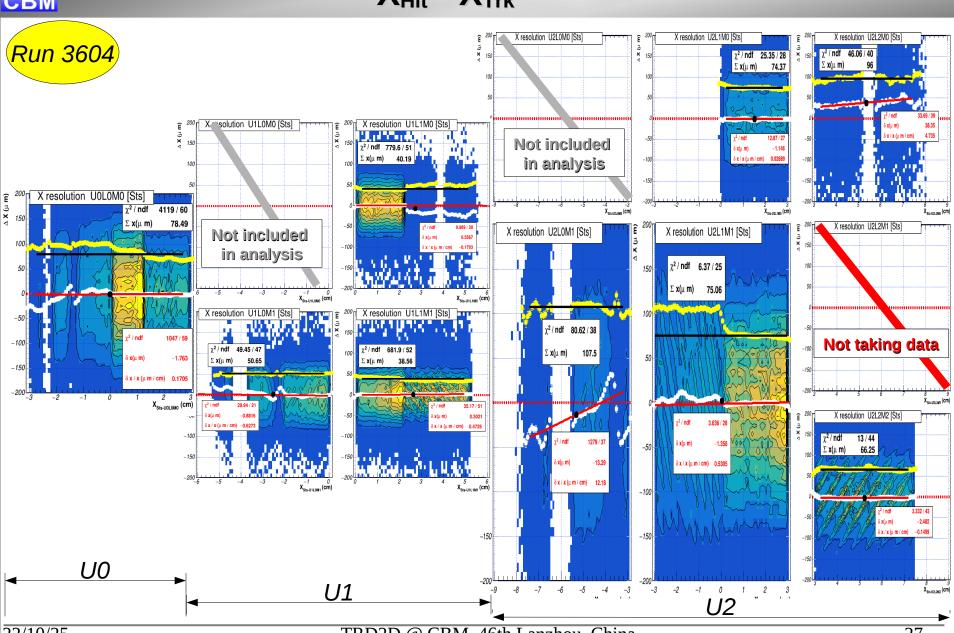




Full STS residuals [mCBM]

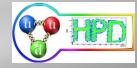


XHit - XTrk

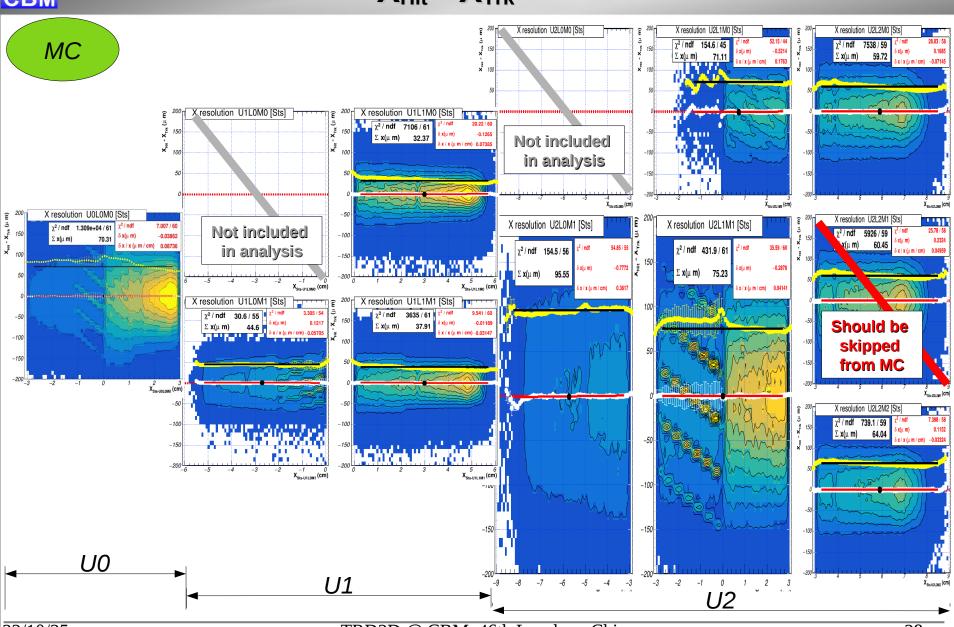




Full STS residuals [MC]



X_{Hit} - X_{Trk}

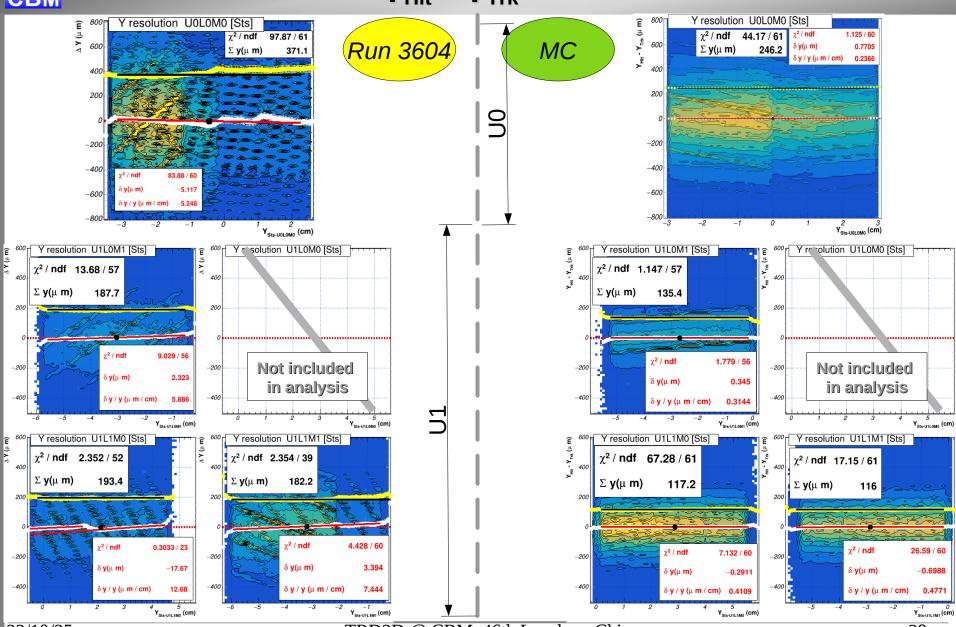




STS residuals [STS/U0 & U1]

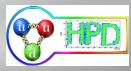


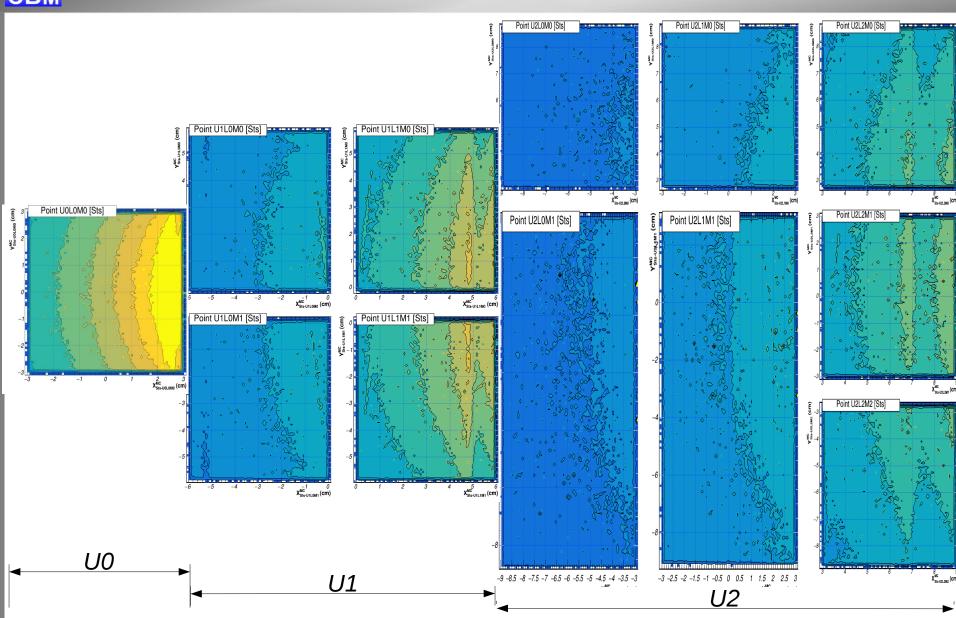
Y_{Hit} - Y_{Trk}





MC production

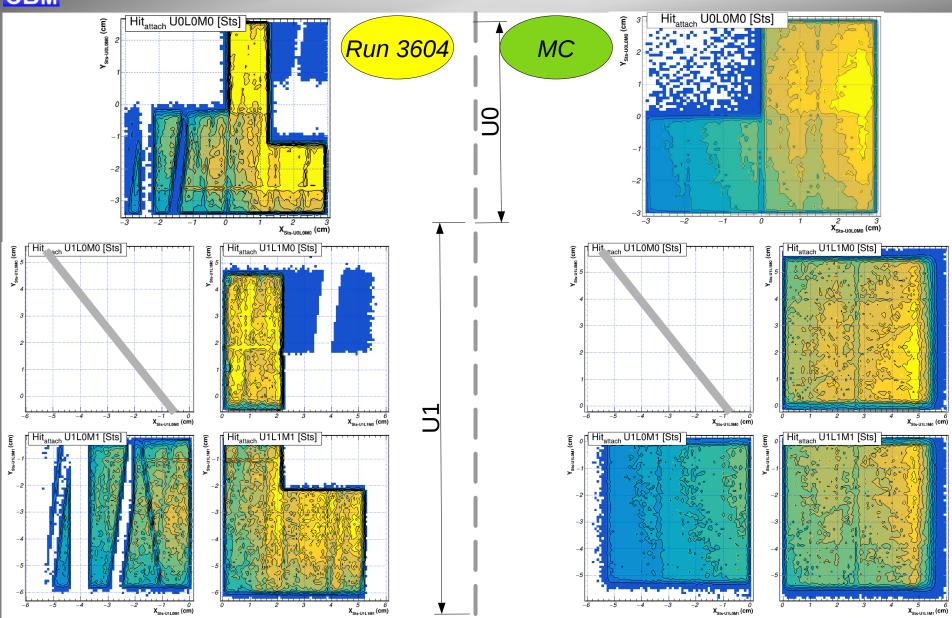






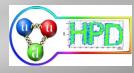
STS hits on long tracks [STS/U0 & U1]

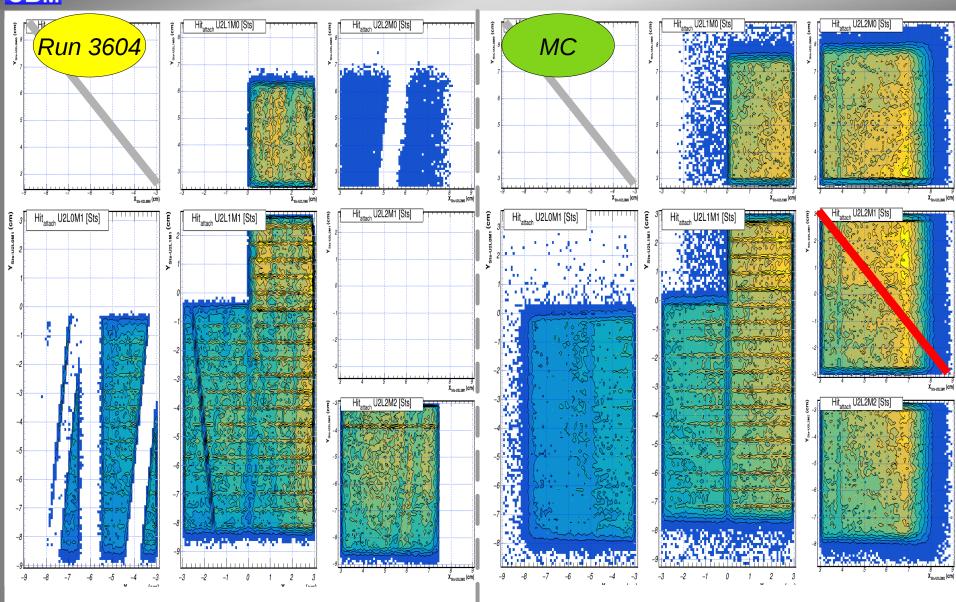






STS hits on long tracks [STS/U2]

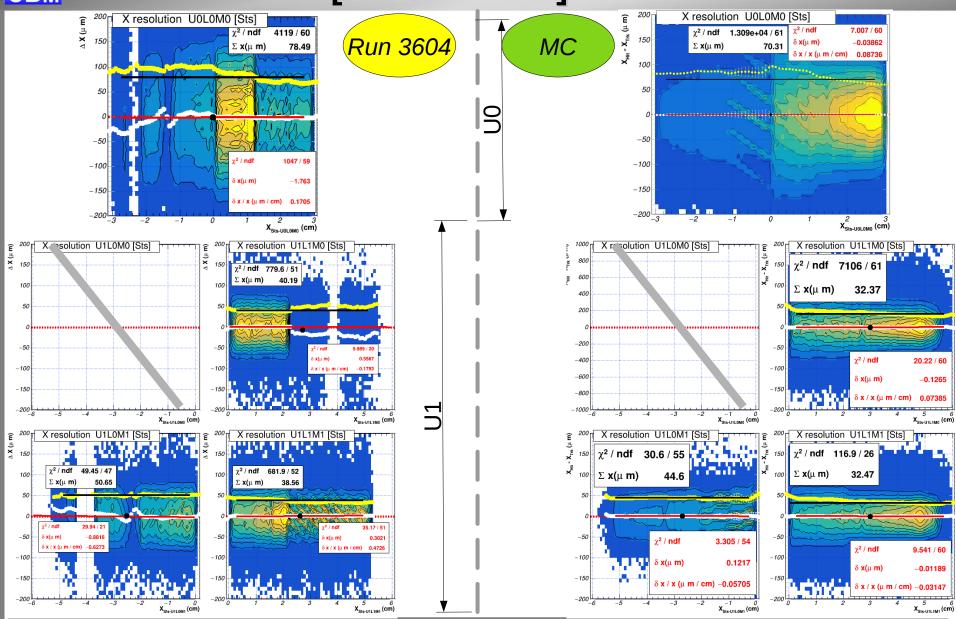






STS x resolution Trk – Hit [STS/U0 & U1]

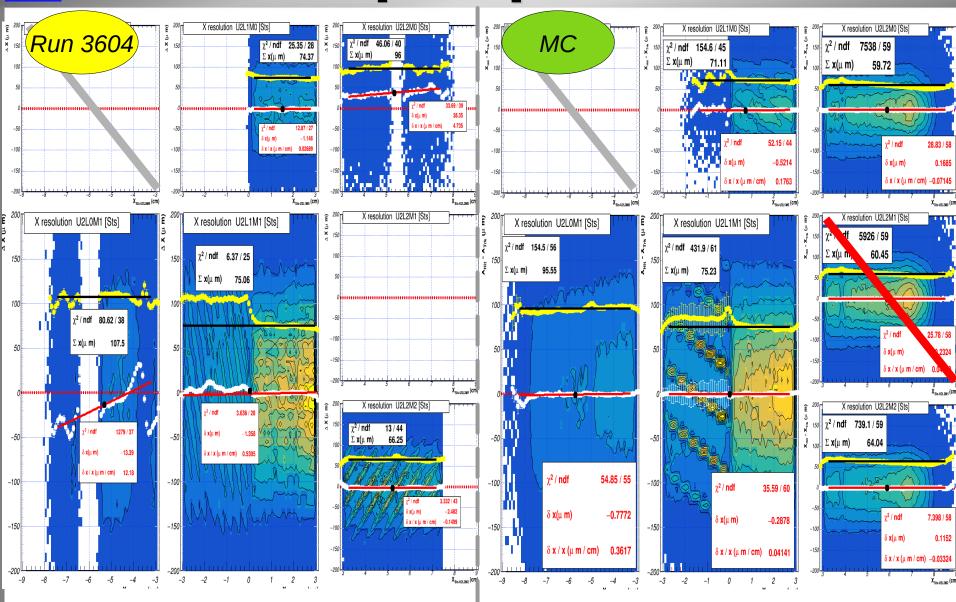






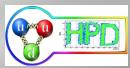
STS x resolution Trk Hit [STS/U2]

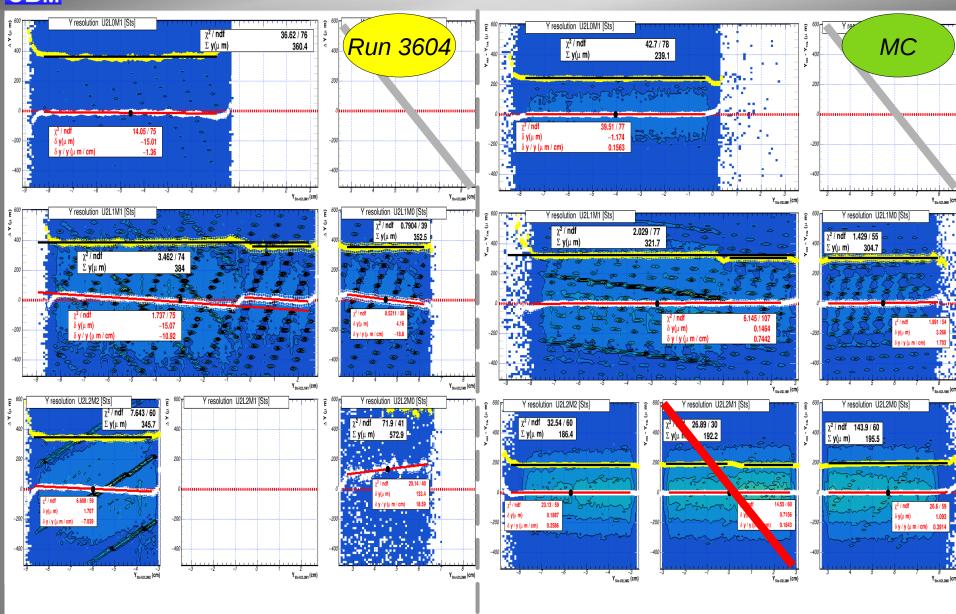






STS y residuals Trk - Hit [STS/U2]

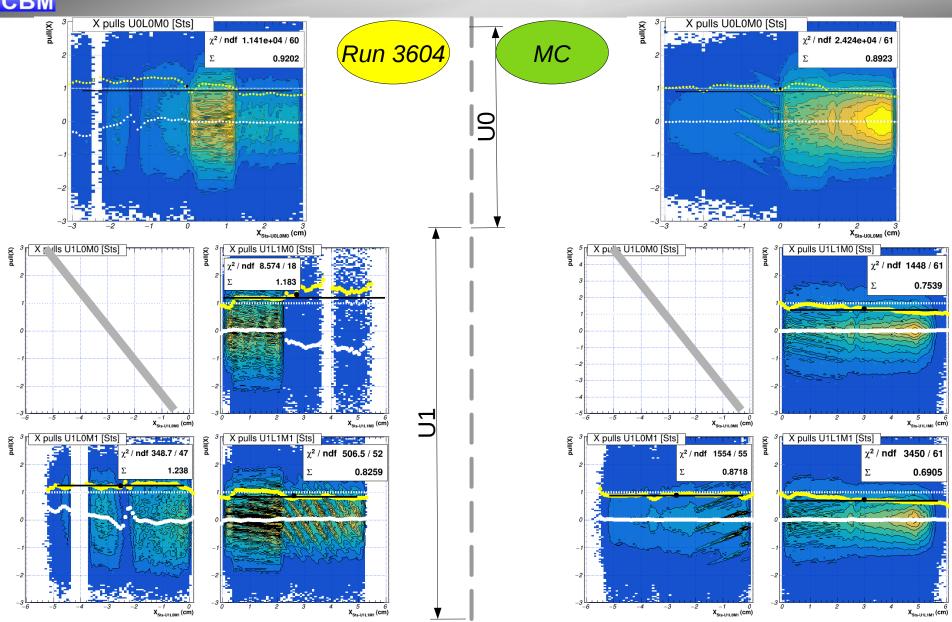






STS x pulls Trk - Hit [STS/U0 & U1]

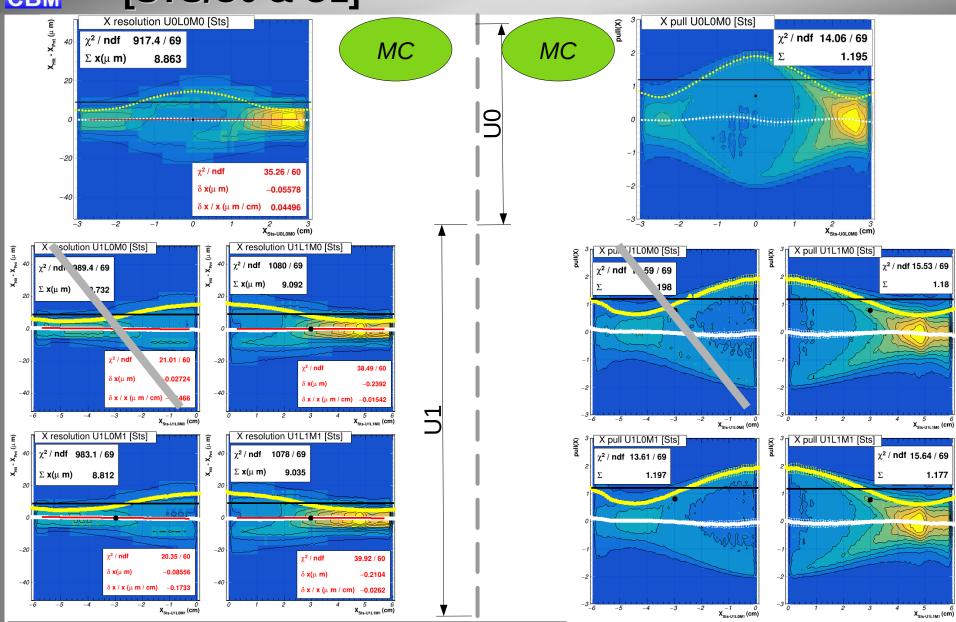






STS x error estimation Hit – Pnt [STS/U0 & U1]

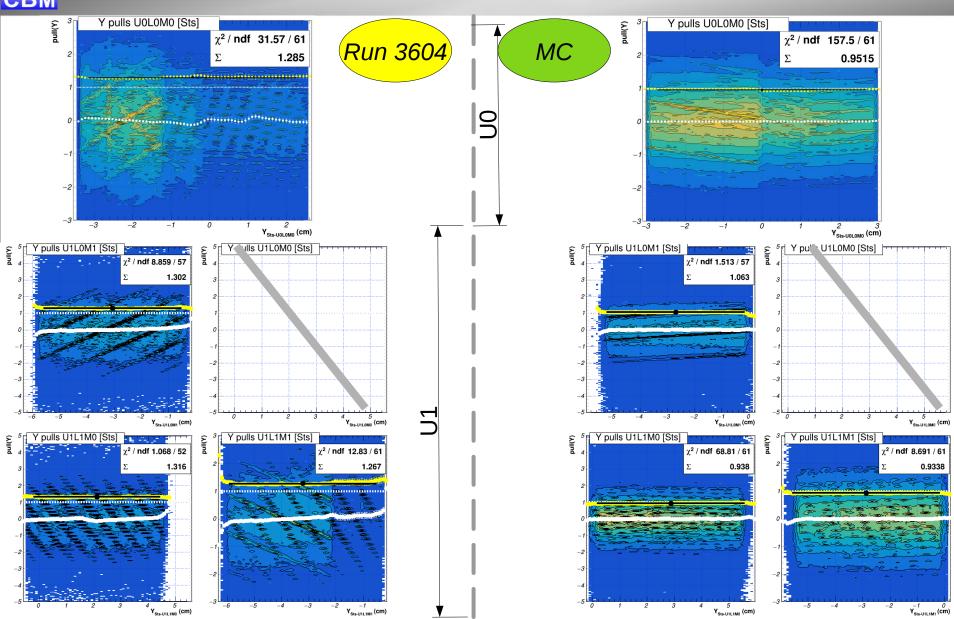






STS y pulls Trk - Hit [STS/U0 & U1]







STS y error estimation Trk – Hit [STS/U0 & U1]



